## Transistors

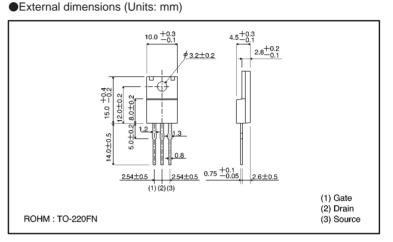
# Switching (250V, 5A) 25K2460N

### Features

- 1) Low on-resistance.
- 2) Fast switching speed.
- Wide SOA (safe operating area).
  Gate-source voltage guaranteed at
- $V_{GSS} = \pm 30V.$
- 5) Easily designed drive circuits.
- 6) Easy to parallel.

## Structure

Silicon N-channel MOSFET



### Absolute maximum ratings (Ta = 25°C)

Parameter		Symbol	Limits	Unit
Drain-source voltage		VDSS	250	V
Gate-source voltage		V <sub>GSS</sub>	±30	V
Drain current	Continuous	lo	5	А
	Pulsed	DP*	20	А
Reverse drain	Continuous	<b>I</b> DR	5	А
current	Pulsed	ldrp*	20	А
Total power dissipation (Tc=25°C)		Po	30	W
Channel temperature		Tch	150	ĉ
Storage temperature		Tstg	-55~+150	Ĉ

\* Pw $\leq$ 10  $\mu$ s, Duty cycle $\leq$ 1%

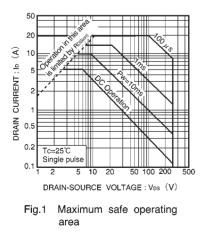
#### Packaging specifications

	Package	Bulk
Туре	Code	_
	Basic ordering unit (pieces)	500
2SK2460N		0

#### Electrical characteristics (Ta = 25°C)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Test Conditions
Gate-source leakage	lass	—	_	±100	nA	$V_{GS}=\pm 30V$ , $V_{DS}=0V$
Drain-source breakdown voltage	V(BR)DSS	250	_	_	V	ID=1mA, VGS=0V
Zero gate voltage drain current	loss	_	_	100	μΑ	V <sub>DS</sub> =250V, V <sub>GS</sub> =0V
Gate threshold voltage	VGS(th)	2.0	_	4.0	V	V <sub>DS</sub> =10V, I <sub>D</sub> =1mA
Static drain-source on-state resistance	RDS(on)	_	0.55	0.75	Ω	ID=2.5A, VGS=10V
Forward transfer admittance	Y <sub>fs</sub>	2.0	3.5	_	S	ID=2.5A, VDS=10V
Input capacitance	Ciss	—	500	_	pF	V <sub>DS</sub> =10V
Output capacitance	Coss	—	150	_	pF	V <sub>GS</sub> =0V
Reverse transfer capacitance	Crss	—	35	_	pF	f=1MHz
Turn-on delay time	td(on)	_	7.0	_	ns	Ib=2.5A, Vbb≑100V
Rise time	tr		15	_	ns	V <sub>GS</sub> =10V
Turn-off delay time	td(off)	_	30	_	ns	$RL=40 \Omega$
Fall time	tr	_	25	_	ns	Rg=10Ω
Reverse recovery time	trr	_	150	_	ns	IDR=5A, VGS=0V
Reverse recovery charge	Qrr	_	0.7	_	μC	di/dt=100A/μs

Electrical characteristic curves



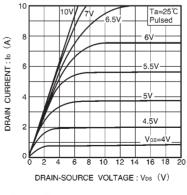
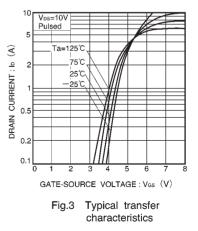
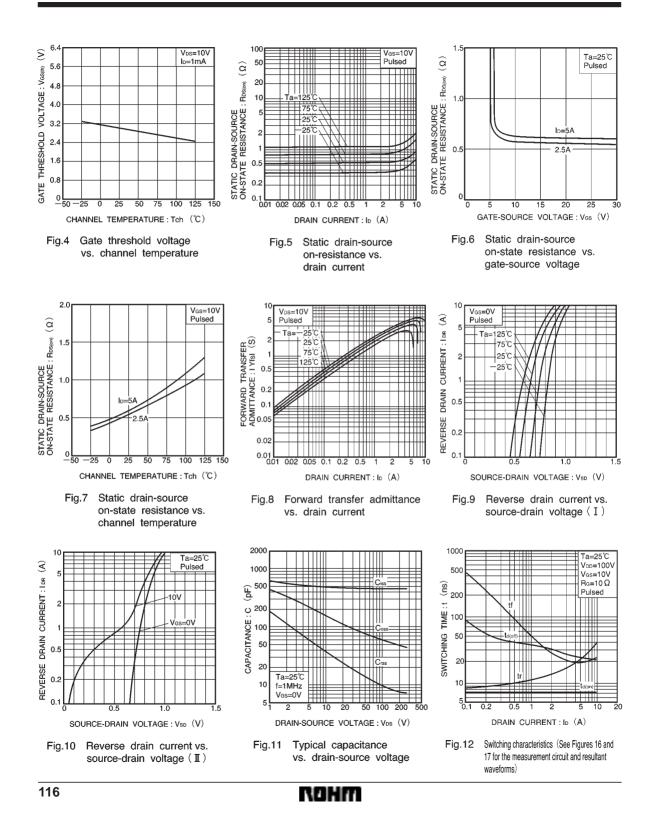
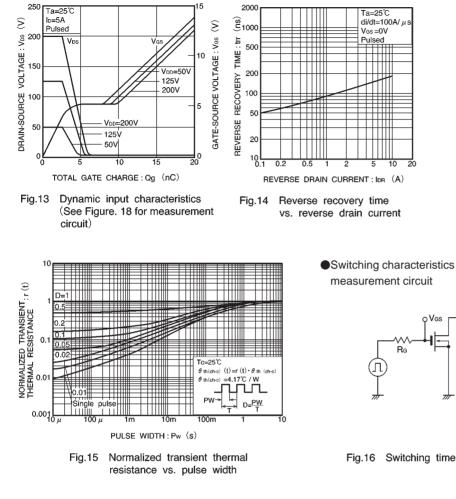


Fig.2 Typical output characteristics



# Transistors





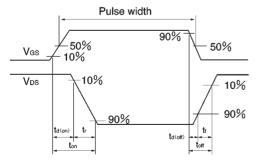


Fig.17 Switching time waveforms

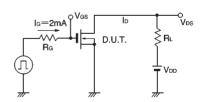


Fig.18 Gate charge measurement circuit

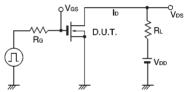


Fig.16 Switching time measurement circuit